

Search Notes

Application/Control No.

10/801,718

Examiner

Daniel Kim

Applicant(s)/Patent under
Reexamination

HIRAIWA ET AL.

Art Unit

2185

SEARCHED

Class	Subclass	Date	Examiner
711	162, 154	12/22/2006	DK
711	161, 170	12/22/2006	DK
711	171, 173	12/22/2006	DK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
711	162	12/22/2006	DK
PGPub Searched		12/22/2006	DK

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Search	12/22/2006	DK
Inventor Name Search for DP	12/22/2006	DK
IEEE Search	12/22/2006	DK